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5.0-5.2GHz, 100W, 50V GaN fully matched PA Module

Description

The SMBV5052-100 is a 100-watt, integrated 2-stage Power Amplifier Module, designed for 5G massive MIMO applications, with frequencies from 5 to 5.2 GHz. The module is 50 Ω input and output fully matched, and requires minimal external components. The module offers a much smaller footprint than traditional discrete component solutions, with much less sensitivity for production, housed in 10*6mm cost effective plastic open cavity package. The module incorporates a Doherty circuit delivering high power added efficiency for the entire module at 16W average power.



Innogration owns the patents for internal Doherty architecture, and related plastic open cavity.

• Typical 1 Carrier WCDMA Performance of Doherty Demo (On Innogration fixture with device soldered):

VDS= 50V, Idq_driver=20mA, Idq_main=90mA,Vpeak=-6.1V				
Pout=42dBm				
Freq (MHz)				ACPR (dBc)
5000	50.39	28.48	40.09	-27.64
5100	50.22	28.58	39.29	-31.11
5200	50.28	27.84	37.23	-35.05

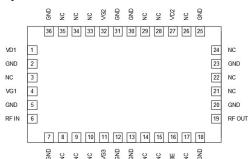
Notes:

(1) WCDMA signal: 3GPP test model 1; 1 to 64 DPCH; Channel Bandwidth=3.84MHz,PAR =10.5 dB at 0.01 % probability on CCDF.

Features

- Industry leading RF performance for 5G MIMO AAU, for instance
- √ 32T:320-400 W / 160-200MHz
- · Plastic open cavity without molding compound brings advantage compared to molded design
- ✓ Minimize the risk of high density thermal distribution in fanless system for longer life time
- ✓ Highly consistent RF performance for yield of volume production
- 50 Ω Input/output matched,
- Integrated Doherty Final and driver Stage
- 6x10 mm Surface Mount Package, full copper flange underneath for grounding and heat dissipation

Pin Configuration and Description



Pin No.	Symbol	Description
1	VD1	Driver Amplifier, Drain Bias
4	VG1	Driver Amplifier, Gate Bias
6	RF IN	RF Input



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11	VG3	Carrier Amplifier, Gate Bias
16	BE	VBW Enhance
19	RF OUT	RF Output
27	VD2	Peaking Amplifier, Drain Bias
32	VG2	Peaking Amplifier, Gate Bias
3,8-10,14-15,17,21,22,24,26,28,29,33-35	NC	No connection
2,5,7,12,13,18,20,23,25,30,31,36	GND	Internal Grounding, recommend connecting to Epad ground
Package Base	GND	DC/RF Ground. Must be soldered to EVB ground plane over array of vias for thermal and RF performance. Solder voids under Pkg Base will result in excessive junction temperatures causing permanent damage.

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
DrainSource Voltage	V _{DSS}	200	Vdc
GateSource Voltage	V _{GS}	-8 to +0.6	Vdc
Operating Voltage	V _{DD}	+55	Vdc
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature	T₃	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance@Average Power, Junction to Case	Rejc	2.9	°C/W
Tcase=+85℃, CW Test, , Pout=16W,	N⊕JC	2.9	C/VV

Notes:

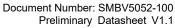
- (1) The thermal resistance is acquired by our company's FEA model, which was calibrated by IR measurement, the value shall be applied to reliability
- (2) The reference Tcase temperature $85\,^{\circ}$ C is apply on the backside of package.
- (3) If the device soldering onto the 20mil Rogers PCB with 50×Φ0.4mm via hole beneath the package backside and the reference temperature Tcase (85°C) apply on the groundside of the PCB, the total thermal resistance R θ JC (TBD)°C/W.
- (4) The power dissipation in the table is overall dissipation which include Carrier PA, Peaking PA and driver PA.

Table 3. ESD Protection Characteristics

Test Methodology	Class Voltage
Human Body Model(HBM) (JEDEC Standard JESD-A114)	TBD
Charged Device Model (CDM) (JEDEC Standard JESD22-C101F)	±1000V

Table 4:Load Mismatch Characteristics (On Test Fixture, 50 ohm system): f = 5.0 GHz

VSWR 10:1 at P3dB pulse CW Output Power	No Device Degradation
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Reference Circuit of Test Fixture Assembly Diagram

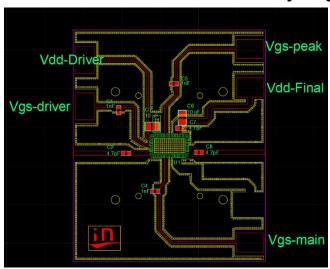


Figure 1. Test Circuit Component Layout

Table 4. Test Circuit Component Designations and Values

Component	Value	Quantity
U1	SMBV5052-100	1
C2、C7、C8	4.7pF	3
C3、C6	10uF/63V	2
C1、C4、C5	1nF	3
PCB	Roger4350B 20mils	

TYPICAL CHARACTERISTICS

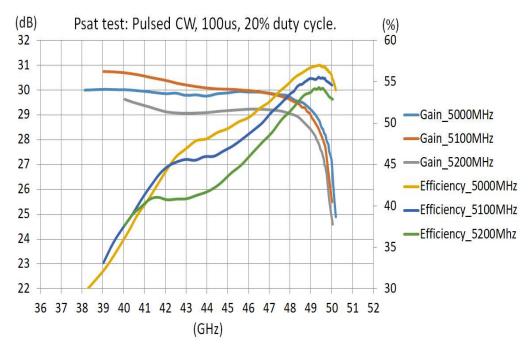


Figure 2. Power Gain and Drain Efficiency as Function of Pulsed CW Output Power



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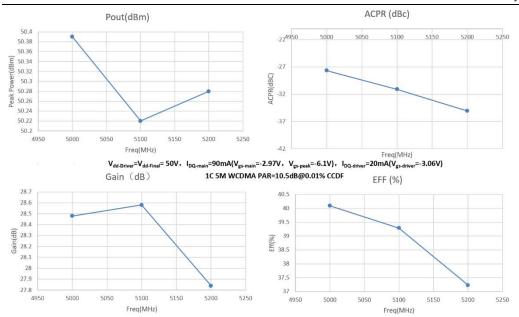


Figure 3. WCDMA performance at Pout=42dBm

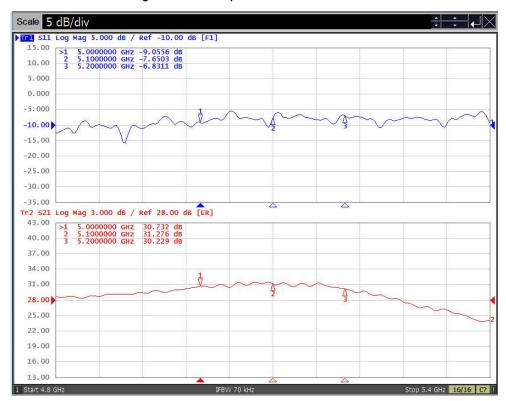
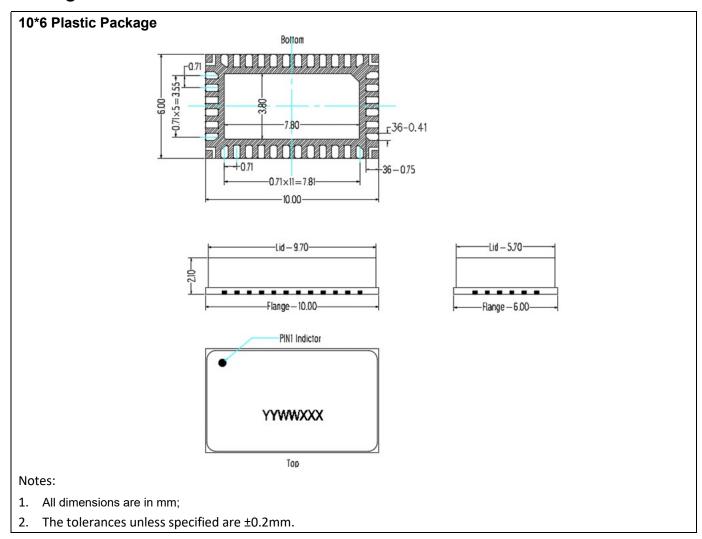


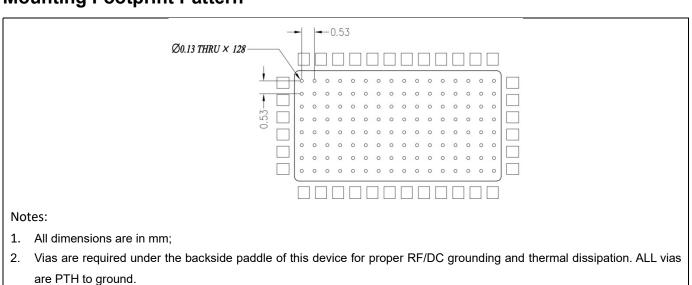
Figure 4. Network analyzer output, S11/S21

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Package Dimensions



Mounting Footprint Pattern





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Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2022/3/2	Rev 1.0	Preliminary Datasheet

Application data based on ZYX-22-02

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